



# PMEG2005AESF

20 V, 0.5 A low VF MEGA Schottky barrier rectifier

6 May 2014

Preliminary data sheet

## 1. General description

Planar Maximum Efficiency General Application (MEGA) Schottky barrier rectifier with an integrated guard ring for stress protection in a DSN0603-2 (SOD962-2) leadless ultra small Surface-Mounted Device (SMD) package.

## 2. Features and benefits

- Average forward current  $I_{F(AV)} \leq 0.5$  A
- Reverse voltage  $V_R \leq 20$  V
- Low forward voltage typ.  $V_F = 245$  mV
- Low reverse current typ.  $I_R = 5$   $\mu$ A
- Ultra small and leadless SMD package
- Package height typ. 0.3 mm

## 3. Applications

- Low voltage rectification
- High efficiency DC-to-DC conversion
- Switch mode power supply
- Low power consumption applications
- Ultra high-speed switching
- LED backlight for mobile application

## 4. Quick reference data

Table 1. Quick reference data

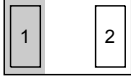

| Symbol      | Parameter               | Conditions  |     | Min | Typ | Max   | Unit    |
|-------------|-------------------------|---|-----|-----|-----|-------|---------|
| $I_{F(AV)}$ | average forward current | $\delta = 0.5$ ; $f = 20$ kHz; $T_{amb} = 115$ °C; square wave                    | [1] | -   | -   | 0.5   | A       |
|             |                         | $\delta = 0.5$ ; $f = 20$ kHz; $T_{sp} = 145$ °C; square wave                     |     | -   | -   | 0.5   | A       |
| $V_R$       | reverse voltage         | $T_j = 25$ °C   |     | -   | -   | 20    | V       |
| $V_F$       | forward voltage         | $I_F = 10$ mA; pulsed; $t_p \leq 300$ $\mu$ s; $\delta \leq 0.02$ ; $T_j = 25$ °C |     | -   | 245 | 310   | mV      |
| $I_R$       | reverse current         | $V_R = 10$ V; $T_j = 25$ °C   |     | -   | 5   | [tbd] | $\mu$ A |
| $t_{rr}$    | reverse recovery time   | $I_R = 500$ mA; $I_F = 500$ mA; $I_{R(meas)} = 100$ mA; $T_j = 25$ °C             |     | -   | 1.9 | -     | ns      |



[1] Device mounted on a ceramic Printed-Circuit Board (PCB), Al<sub>2</sub>O<sub>3</sub>, standard footprint.

## 5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline   | Graphic symbol  |
|-----|--------|-------------|--|---|
| 1   | K      | cathode[1]  |  <p>Transparent top view<br/>DSN0603-2 (SOD962-2)</p> | <br>sym001 |
| 2   | A      | anode       |  |   |

[1] The marking bar indicates the cathode.

## 6. Ordering information

Table 3. Ordering information

| Type number  | Package   |  |          |
|--------------|-----------|--|----------|
|              | Name      | Description  | Version  |
| PMEG2005AESF | DSN0603-2 | Leadless ultra small package; 2 terminals; body 0.6 x 0.3 x 0.3 mm | SOD962-2 |

## 7. Marking

Table 4. Marking codes

| Type number  | Marking code |
|--------------|--------------|
| PMEG2005AESF | 6            |

## 8. Limiting values

**Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol      | Parameter                           | Conditions  |     | Min | Max  | Unit |
|-------------|-------------------------------------|---|-----|-----|------|------|
| $V_R$       | reverse voltage                     | $T_j = 25\text{ °C}$  |     | -   | 20   | V    |
| $I_F$       | forward current                     | $T_{sp} \leq 140\text{ °C}$   |     | -   | 0.71 | A    |
| $I_{F(AV)}$ | average forward current             | $\delta = 0.5$ ; $f = 20\text{ kHz}$ ; $T_{amb} = 115\text{ °C}$ ;<br>square wave | [1] | -   | 0.5  | A    |
|             |                                     | $\delta = 0.5$ ; $f = 20\text{ kHz}$ ; $T_{sp} = 145\text{ °C}$ ;<br>square wave  |     | -   | 0.5  | A    |
| $I_{FRM}$   | repetitive peak forward current     | $t_p \leq 1\text{ ms}$ ; $\delta \leq 0.25$                                       |     | -   | 2    | A    |
| $I_{FSM}$   | non-repetitive peak forward current | $t_p = 8\text{ ms}$ ; $T_{j(init)} = 25\text{ °C}$ ; square wave                  |     | -   | 4.5  | A    |
| $P_{tot}$   | total power dissipation             | $T_{amb} \leq 25\text{ °C}$   | [2] | -   | 405  | mW   |
|             |                                     |   | [3] | -   | 660  | mW   |
|             |                                     |   | [1] | -   | 1200 | mW   |
| $T_j$       | junction temperature                |   |     | -   | 150  | °C   |
| $T_{amb}$   | ambient temperature                 |   |     | -55 | 150  | °C   |
| $T_{stg}$   | storage temperature                 |   |     | -65 | 150  | °C   |

[1] Device mounted on a ceramic Printed-Circuit Board (PCB),  $Al_2O_3$ , standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for anode and cathode  $1\text{ cm}^2$  each.

### 9. Thermal characteristics

Table 6. Thermal characteristics

| Symbol                | Parameter  | Conditions  |        | Min | Typ | Max | Unit |
|-----------------------|--|-------------|--------|-----|-----|-----|------|
| R <sub>th(j-a)</sub>  | thermal resistance from junction to ambient      | in free air | [1][2] | -   | -   | 310 | K/W  |
|                       |  |             | [1][3] | -   | -   | 190 | K/W  |
|                       |  |             | [1][4] | -   | -   | 105 | K/W  |
| R <sub>th(j-sp)</sub> | thermal resistance from junction to solder point |             | [5]    | -   | -   | 40  | K/W  |

- [1] For Schottky barrier diodes thermal runaway has to be considered, as in some applications the reverse power losses P<sub>R</sub> are a significant part of the total power losses.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for anode and cathode 1 cm<sup>2</sup> each.
- [4] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.
- [5] Soldering point of cathode tab.

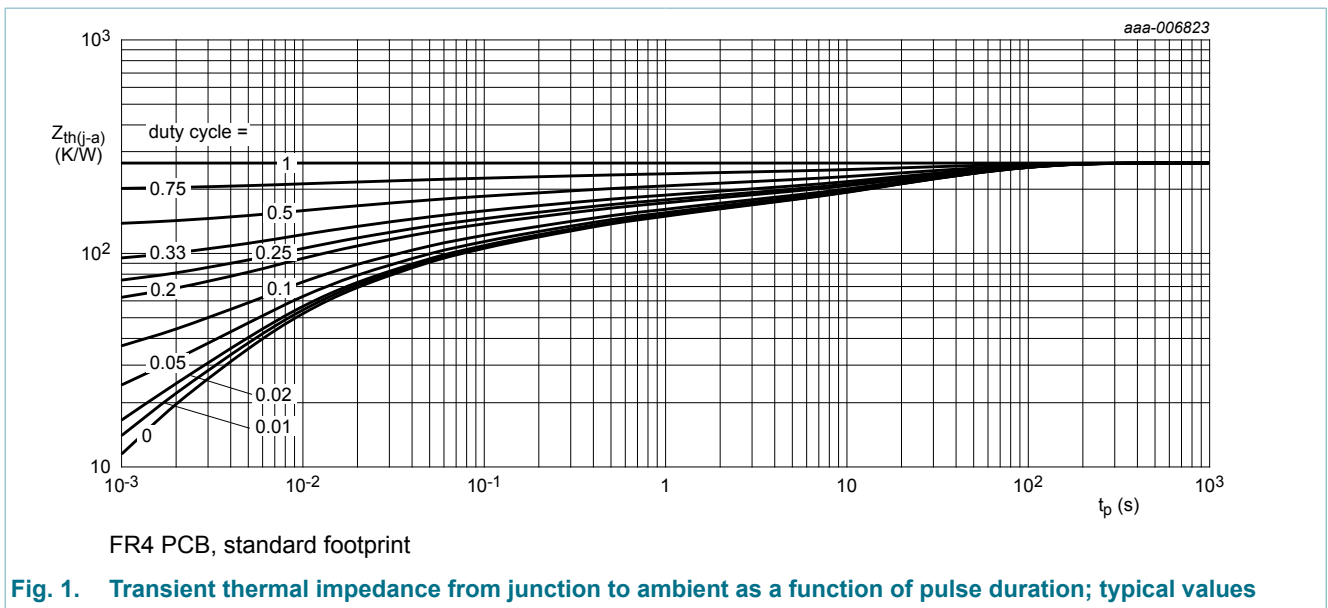
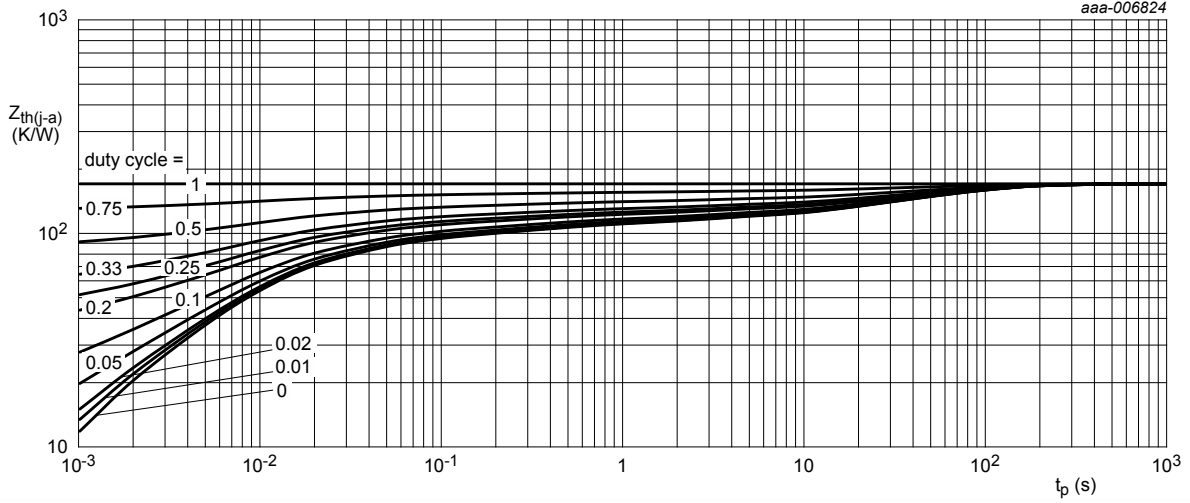
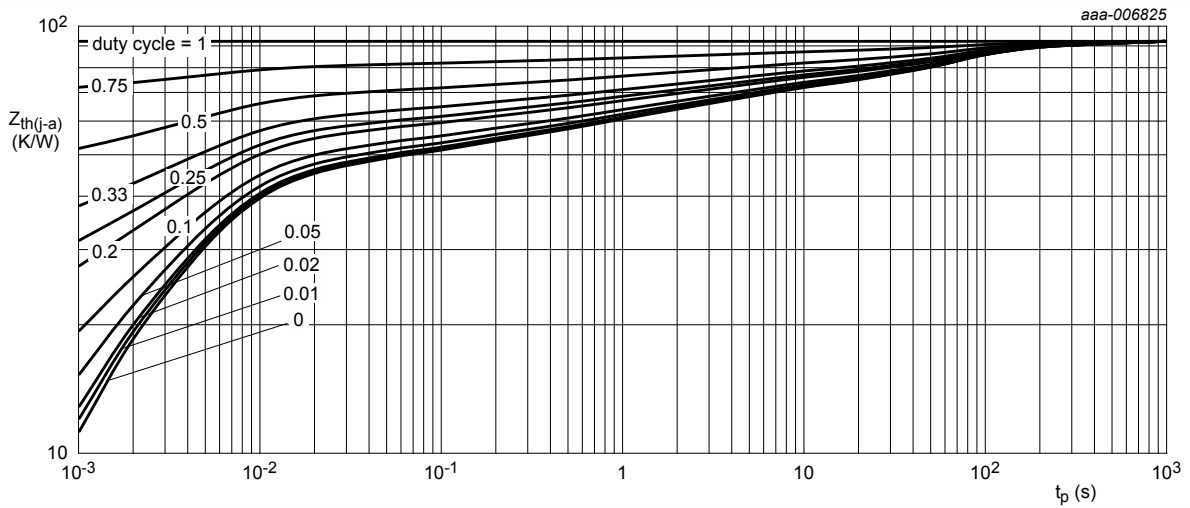


Fig. 1. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



FR4 PCB, mounting pad for anode and cathode 1 cm<sup>2</sup> each

Fig. 2. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



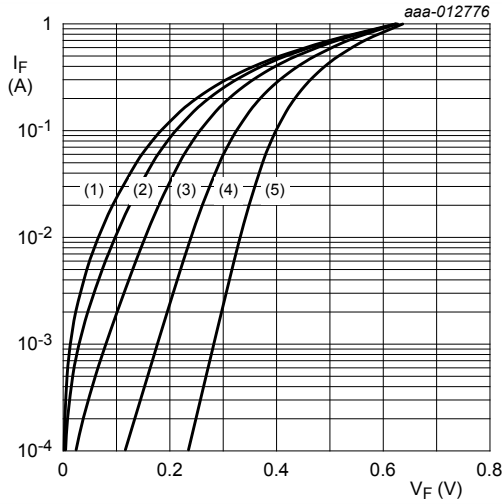
Ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint

Fig. 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

## 10. Characteristics

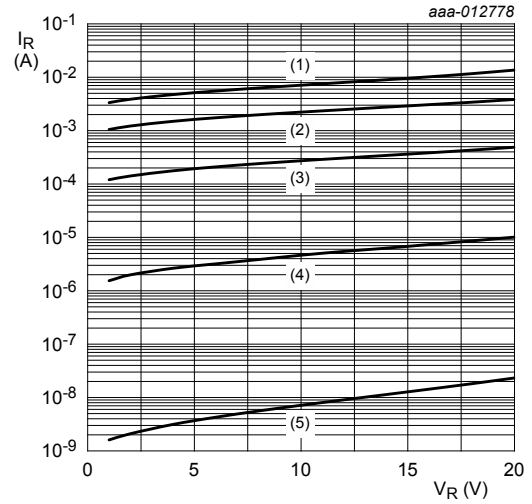
Table 7. Characteristics

| Symbol          | Parameter             | Conditions   | Min | Typ | Max   | Unit |
|-----------------|-----------------------|--|-----|-----|-------|------|
| V <sub>F</sub>  | forward voltage       | I <sub>F</sub> = 0.1 mA; pulsed; t <sub>p</sub> ≤ 300 μs;<br>δ ≤ 0.02; T <sub>j</sub> = 25 °C              | -   | 120 | 180   | mV   |
|                 |                       | I <sub>F</sub> = 1 mA; pulsed; t <sub>p</sub> ≤ 300 μs; δ ≤ 0.02;<br>T <sub>j</sub> = 25 °C                | -   | 180 | 250   | mV   |
|                 |                       | I <sub>F</sub> = 10 mA; pulsed; t <sub>p</sub> ≤ 300 μs;<br>δ ≤ 0.02; T <sub>j</sub> = 25 °C               | -   | 245 | 310   | mV   |
|                 |                       | I <sub>F</sub> = 100 mA; pulsed; t <sub>p</sub> ≤ 300 μs;<br>δ ≤ 0.02; T <sub>j</sub> = 25 °C              | -   | 330 | 380   | mV   |
|                 |                       | I <sub>F</sub> = 200 mA; pulsed; t <sub>p</sub> ≤ 300 μs;<br>δ ≤ 0.02; T <sub>j</sub> = 25 °C              | -   | 375 | [tbd] | mV   |
|                 |                       | I <sub>F</sub> = 500 mA; pulsed; t <sub>p</sub> ≤ 300 μs;<br>δ ≤ 0.02; T <sub>j</sub> = 25 °C              | -   | 475 | [tbd] | mV   |
| I <sub>R</sub>  | reverse current       | V <sub>R</sub> = 6 V; T <sub>j</sub> = 25 °C   | -   | 3.2 | -     | μA   |
|                 |                       | V <sub>R</sub> = 10 V; T <sub>j</sub> = 25 °C  | -   | 5   | [tbd] | μA   |
|                 |                       | V <sub>R</sub> = 20 V; T <sub>j</sub> = 25 °C  | -   | 10  | 45    | μA   |
| C <sub>d</sub>  | diode capacitance     | V <sub>R</sub> = 1 V; f = 1 MHz; T <sub>j</sub> = 25 °C  | -   | 25  | -     | pF   |
|                 |                       | V <sub>R</sub> = 10 V; f = 1 MHz; T <sub>j</sub> = 25 °C   | -   | 10  | -     | pF   |
| t <sub>rr</sub> | reverse recovery time | I <sub>F</sub> = 500 mA; I <sub>R</sub> = 500 mA;<br>I <sub>R(meas)</sub> = 100 mA; T <sub>j</sub> = 25 °C | -   | 1.9 | -     | ns   |



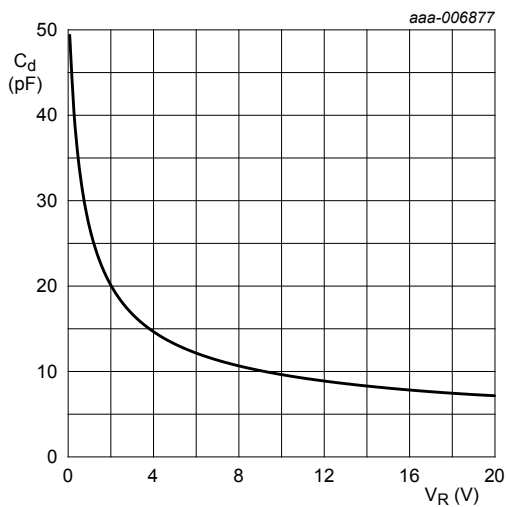
- (1)  $T_j = 150\text{ }^\circ\text{C}$
- (2)  $T_j = 125\text{ }^\circ\text{C}$
- (3)  $T_j = 85\text{ }^\circ\text{C}$
- (4)  $T_j = 25\text{ }^\circ\text{C}$
- (5)  $T_j = -40\text{ }^\circ\text{C}$

**Fig. 4. Forward current as a function of forward voltage; typical values**



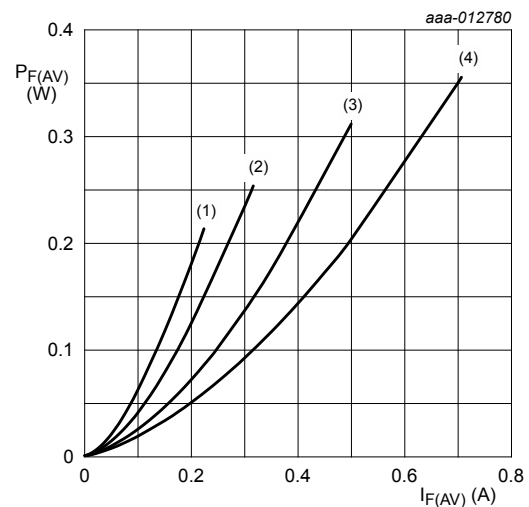
- (1)  $T_j = 150\text{ }^\circ\text{C}$
- (2)  $T_j = 125\text{ }^\circ\text{C}$
- (3)  $T_j = 85\text{ }^\circ\text{C}$
- (4)  $T_j = 25\text{ }^\circ\text{C}$
- (5)  $T_j = -40\text{ }^\circ\text{C}$

**Fig. 5. Reverse current as a function of reverse voltage; typical values**



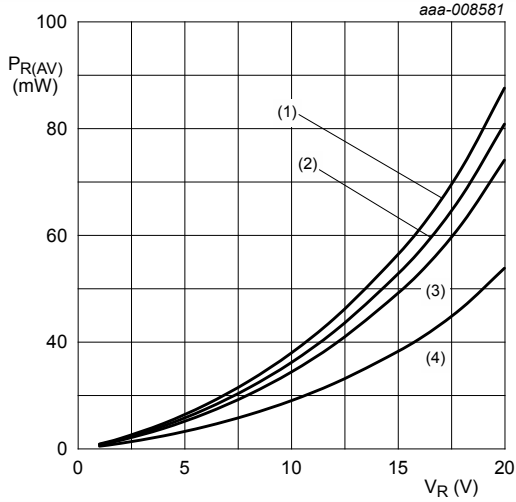
$f = 1\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$

**Fig. 6. Diode capacitance as a function of reverse voltage; typical values**



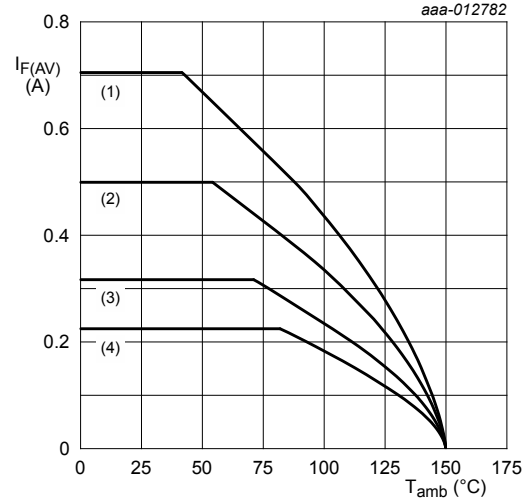
- $T_j = 150\text{ }^\circ\text{C}$
- (1)  $\delta = 0.1$
- (2)  $\delta = 0.2$
- (3)  $\delta = 0.5$
- (4)  $\delta = 1$

**Fig. 7. Average forward power dissipation as a function of average forward current; typical values**



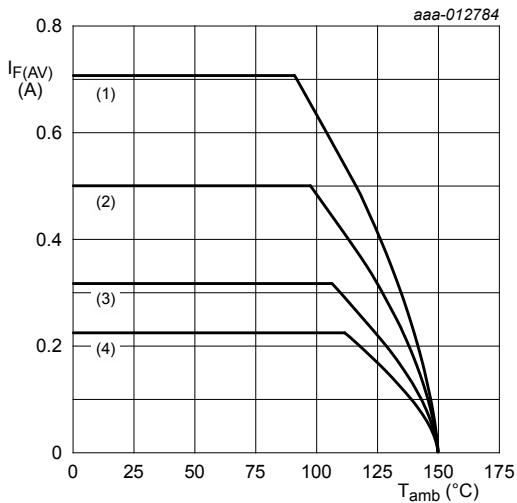
$T_j = 125\text{ °C}$   
 (1)  $\delta = 1$   
 (2)  $\delta = 0.9$   
 (3)  $\delta = 0.8$   
 (4)  $\delta = 0.5$

**Fig. 8.** Average reverse power dissipation as a function of reverse voltage; typical values



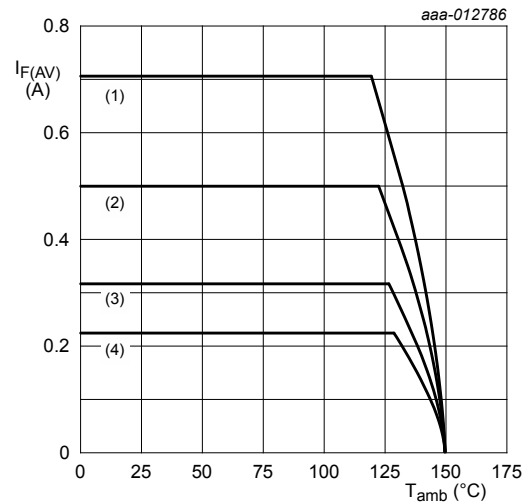
FR4 PCB, standard footprint  
 $T_j = 150\text{ °C}$   
 (1)  $\delta = 1$ ; DC  
 (2)  $\delta = 0.5$ ;  $f = 20\text{ kHz}$   
 (3)  $\delta = 0.2$ ;  $f = 20\text{ kHz}$   
 (4)  $\delta = 0.1$ ;  $f = 20\text{ kHz}$

**Fig. 9.** Average forward current as a function of ambient temperature; typical values



FR4 PCB, mounting pad for anode and cathode  
 $1\text{ cm}^2$  each  
 $T_j = 150\text{ °C}$   
 (1)  $\delta = 1$ ; DC  
 (2)  $\delta = 0.5$ ;  $f = 20\text{ kHz}$   
 (3)  $\delta = 0.2$ ;  $f = 20\text{ kHz}$   
 (4)  $\delta = 0.1$ ;  $f = 20\text{ kHz}$

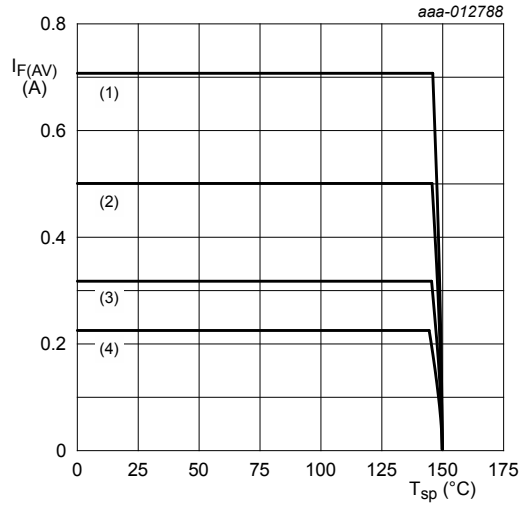
**Fig. 10.** Average forward current as a function of ambient temperature; typical values



Ceramic PCB,  $\text{Al}_2\text{O}_3$ , standard footprint  
 $T_j = 150\text{ °C}$   
 (1)  $\delta = 1$ ; DC  
 (2)  $\delta = 0.5$ ;  $f = 20\text{ kHz}$   
 (3)  $\delta = 0.2$ ;  $f = 20\text{ kHz}$   
 (4)  $\delta = 0.1$ ;  $f = 20\text{ kHz}$

**Fig. 11.** Average forward current as a function of ambient temperature; typical values





$T_j = 150$  °C

(1)  $\delta = 1$ ; DC

(2)  $\delta = 0.5$ ;  $f = 20$  kHz

(3)  $\delta = 0.2$ ;  $f = 20$  kHz

(4)  $\delta = 0.1$ ;  $f = 20$  kHz

**Fig. 12. Average forward current as a function of solder point temperature; typical values**

### 11. Test information

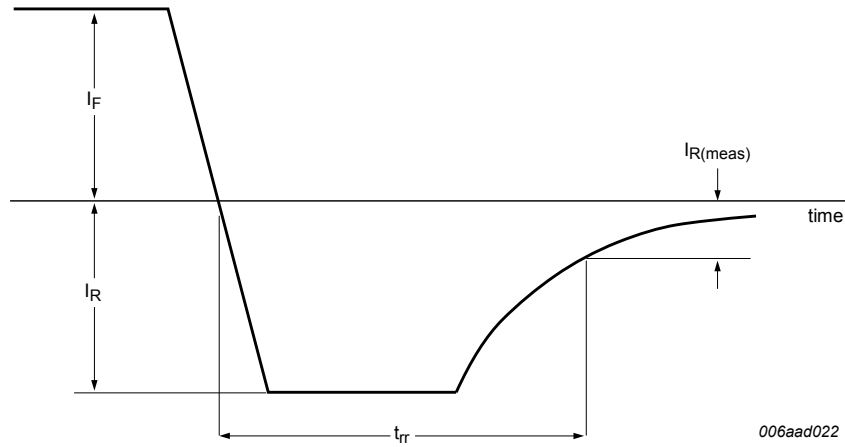


Fig. 13. Reverse recovery definition

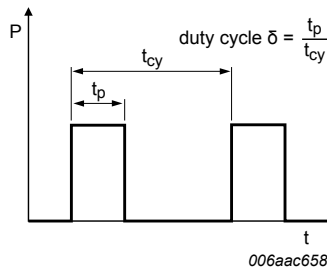


Fig. 14. Duty cycle definition

The current ratings for the typical waveforms are calculated according to the equations:  $I_{F(AV)} = I_M \times \delta$  with  $I_M$  defined as peak current,  $I_{RMS} = I_{F(AV)}$  at DC, and  $I_{RMS} = I_M \times \sqrt{\delta}$  with  $I_{RMS}$  defined as RMS current.

## 12. Package outline

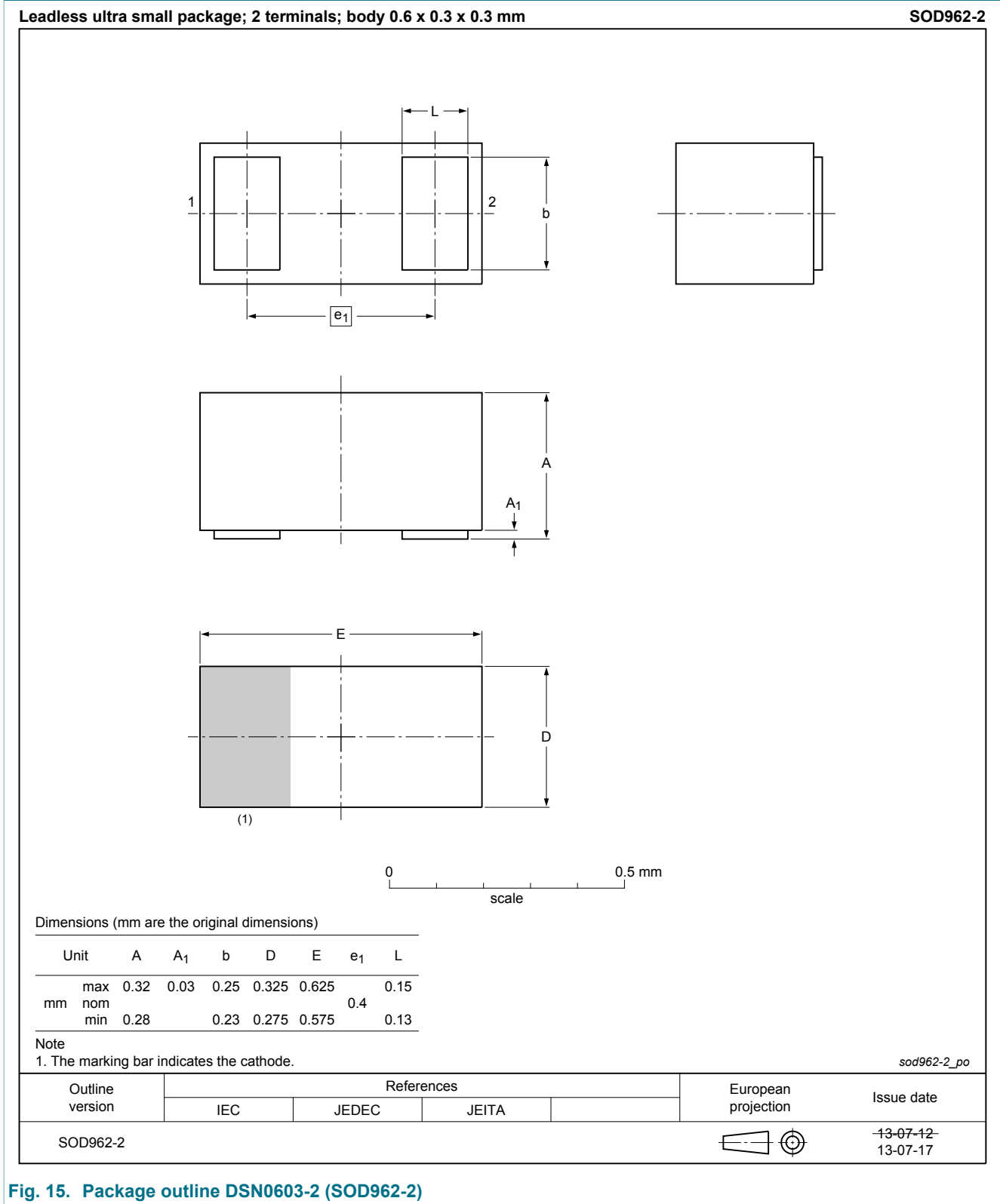
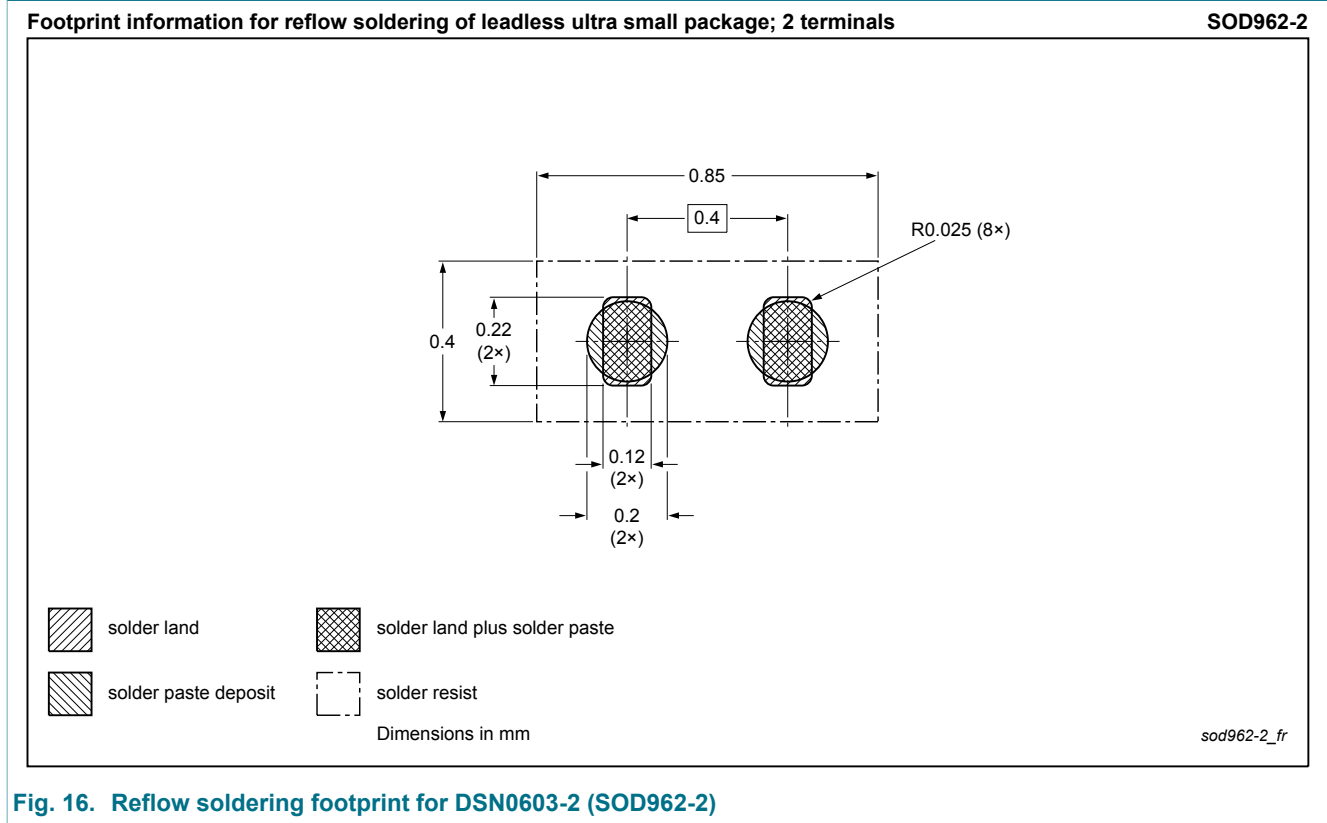


Fig. 15. Package outline DSN0603-2 (SOD962-2)

### 13. Soldering



## 14. Revision history

Table 8. Revision history

| Data sheet ID    | Release date | Data sheet status      | Change notice | Supersedes |
|------------------|--------------|------------------------|---------------|------------|
| PMEG2005AESF v.1 | 20140506     | Preliminary data sheet | -             | -          |

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|--------------------------------|--------------------|---|
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Date of release: 6 May 2014